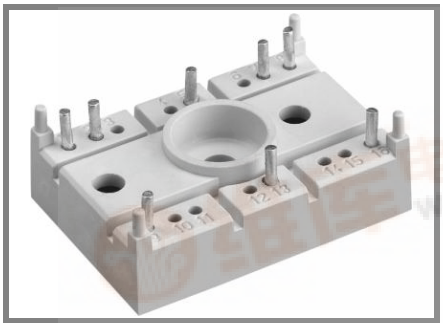
SK 9 GD 065



SEMITOP® 2

IGBT Module

SK 9 GD 065

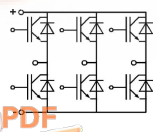
Target Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Ultrafast NPT technology IGBT
- CAL technology FWD

Typical Applications

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



GD

Absolute Maximum Ratings T_s = 25 °C, unless otherwise specified

Symbol	Conditions	Values	Units
IGBT			
V_{CES}		600	V
V_{GES}		± 20	V
I_C	T_s = 25 (80) °C;	11 (8)	A
I_{CM}	t_p < 1 ms; T_s = 25 (80) °C;	22 (16)	A
T_j		- 40 ... + 150	°C
Inverse/Freewheeling CAL Diode			
I_F	T_s = 25 (80) °C;	22 (15)	A
I_{FM} = - I_{CM}	t_p < 1 ms; T_s = 25 (80) °C;	44 (30)	A
T_j		- 40 ... + 150	°C
T_{stg}		- 40 ... + 125	°C
T_{sol}	Terminals, 10 s	260	°C
V_{isol}	AC 50 Hz, r.m.s. 1 min. / 1 s	2500 / 3000	V

Characteristics T_s = 25 °C, unless otherwise specified

Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{CE(sat)}$	I_C = 6 A, T_j = 25 (125) °C		2 (2,2)	2,5 (7,7)	V
$V_{GE(th)}$	V_{CE} = V_{GE}; I_C = 0,0005 A	3	4	5	V
C_{ies}	V_{CE} = 25 V; V_{GE} = 0 V; 1 MHz		0,32		nF
$R_{th(j-s)}$	per IGBT			2,6	K/W
	per module				K/W
	under following conditions:				
$t_{d(on)}$	V_{CC} = 300 V , V_{GE} = ± 15 V		20		ns
t_r	I_C = 6 A, T_j = 125 °C		25		ns
$t_{d(off)}$	R_{Gon} = R_{Goff} = 120 Ω		145		ns
t_f			25		ns
E_{on} + E_{off}	Inductive load		0,34		mJ
Inverse/Freewheeling CAL Diode					
V_F = V_{EC}	I_F = 15 A; T_j = 25 (125) °C		1,4 (1,4)	1,7 (1,7)	V
$V_{(TO)}$	T_j = 25 (125) °C		1 (0,9)	1,1 (1)	V
r_T	T_j = 25 (125) °C		30 (33)	40 (47)	mΩ
$R_{th(j-s)}$				2,3	K/W
	under following conditions:				
I_{RRM}	I_F = 15 A; V_R = 300 V		22		A
Q_{rr}	dI_F/dt = 1100 A/µs		1,5		µC
E_{off}	V_{GE} = 0 V; T_j = 125 °C		0,31		mJ
Mechanical data					
M1	mounting torque			2	Nm
w			21		g
Case	SEMITOP® 2		T 47		

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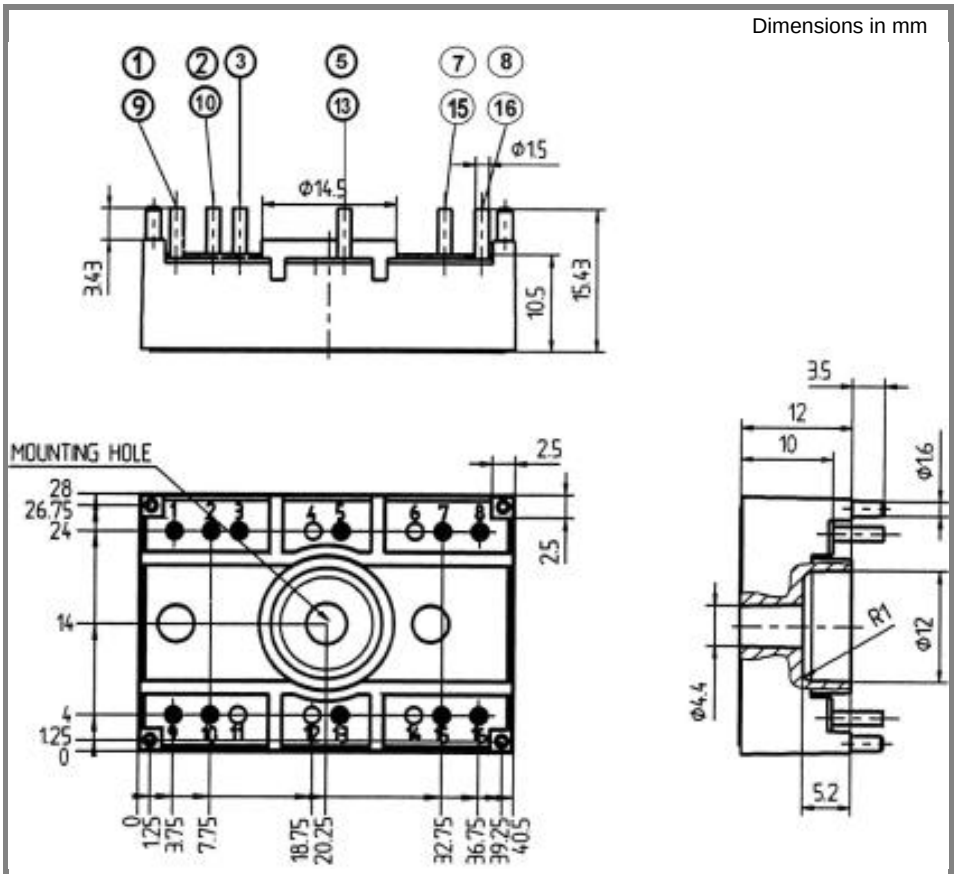
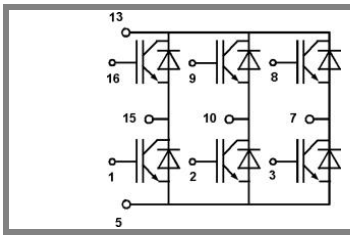
Dimensions in mm



SUGGESTED HOLEDIAMETER FOR THE SOLDER PINS AND THE MOUNTING PINS IN THE PCB: 2 mm

Case T47



Case T 47 GD

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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